

A CMOS Micro-power, Class-AB “Flipped” Voltage Follower using the quasi floating-gate technique

Circuito CMOS seguidor de voltaje “rotado” de micro-potencia con salida clase AB usando Técnicas de Compuerta Cuasi-flotante

J.J. Ocampo-Hidalgo¹, I. Vázquez-Álvarez², S. Sandoval-Perez³, R. Z. García-Lozano⁴, M. A. Gurrola⁵, and J. E. Molinar-Solis⁶

ABSTRACT

This paper presents the design and characterization of a new analog voltage follower for low-voltage applications. The main idea is based on the “Flipped” Voltage Follower and the use of the quasi-floating gate technique for achieving class AB operation. A test cell was simulated and fabricated using a 0,5 μm CMOS technology. When the proposed circuit is supplied with $V_{DD}=1,5\text{V}$, it presents a power consumption of only 413 μW . Measurement and experimental results show a gain-bandwidth product of 10MHz and a total harmonic distortion of 1,12% at 1MHz.

Keywords: CMOS analog integrated circuit design, quasi-floating gate circuits, low voltage, micro-power.

RESUMEN

En este trabajo se presenta el diseño y caracterización de un nuevo seguidor de voltaje analógico para aplicaciones de bajo voltaje. La idea principal aquí desarrollada, está basada en el Seguidor de Voltaje “Volteado” y el uso de técnicas de compuerta casi-flotante para lograr un funcionamiento de clase AB. Usando una tecnología CMOS de 0.5 μm , se simuló y se fabricó una celda de prueba. Cuando el circuito propuesto se alimenta con $V_{DD}=1,5\text{V}$, este presenta un consumo de potencia de tan solo 413 μW . Las mediciones y los resultados experimentales muestran un producto ganancia-ancho de banda de 10MHz y una distorsión armónica total de 1,12% a 1MHz.

Palabras clave: Diseño de circuitos integrados CMOS analógicos, compuerta flotante, bajo voltaje, micro-potencia.

Received: February 13th 2017

Accepted: June 26th 2017

Introduction

Voltage followers or buffers are basic analog building blocks widely used as output stage in integrated circuits to drive low-level signals into loads owning large capacity. Thus, a good voltage follower should have: small input-capacitance together with high input-resistance as well as low-output resistance. Besides, it must be capable to deliver high output-current provided a low supply voltage, to preserve low-power consumption. Since designing an electronic circuit, where both large slew-rate and low-power consumption are demanded, conducts to contradictory constraints, traditional circuit techniques and topologies such as the well-known common-drain amplifier (Carusone, 2012) have been improved by means of innovative circuit techniques. Thus, during the past fifteen years, different circuit approaches have been proposed, such techniques range from the use of multiple-input floating-gate transistors (Ramirez-Angulo, 1995), Quasi-Floating-Gate (QFG) transistors (Ramirez-Angulo, 2003), and recently bulk-driven techniques (Haga, 2009). This last approach has become popular because it bases its low-power supply performance-capability in the reduction of the threshold voltage of P-MOS transistors by means of the body effect (Tsvividis, 2010). However, it shows two main drawbacks when the bulk terminal is untied from the

¹ B. Sc. Electronics Engineering, ESIME-IPN, Mexico. M. Sc. in Electrical Engineering, Cinvestav, Mexico. Ph.D. in Electrical Engineering, TU Darmstadt, Germany. Afiliation: Universidad Autónoma Metropolitana Azcapotzalco. E-mail: jjoh@correo.azc.uam.mx

² B. Sc. Electronics Engineering, UAM-Azc, Mexico. M. Sc. in Electrical Engineering, Cinvestav, Mexico. Ph.D. in Electrical Engineering, Lomonosov Moscow State University, Russian Fed. Afiliation: Universidad Autónoma Metropolitana Azcapotzalco. E-mail: iva@correo.azc.uam.mx

³ B. Sc. Electronics Engineering, ITCG, Mexico. Ph.D. in Computer and Automation, UdeG, Mexico. Afiliation: Instituto Tecnológico de Cd Guzman. E-mail: ssandoval@itcg.edu.mx

⁴ B. Sc. Electronics Engineering, TESE, Mexico. Ph.D. in Electrical Engineering, Cinvestav, Mexico. Afiliation: Universidad Autónoma del Estado de México. E-mail: rzgarcial@uaemex.mx

⁵ B. Sc. Electronics Engineering, UdeG, Mexico, PhD. INAOE, Mexico. Afiliation: Universidad de Guadalajara, Mexico. E-mail: marco.gurrola@cupei.udg.mx

⁶ B. Sc. Electronics Engineering, ITCG, Mexico. M. Sc. and Ph.D. in Electrical Engineering, Cinvestav, Mexico. Afiliation: Instituto Tecnológico de Cd Guzman. E-mail: jemolinar@itcg.edu.mx

How to cite: Ocampo-Hidalgo, J. J., Vázquez-Álvarez, I., Sandoval-Perez, S., García-Lozano, R. Z., Gurrola, M. A., and Molinar-Solis, J. E. (2017). A CMOS Micro-power, Class-AB “Flipped” Voltage Follower using the Quasi floating-gate Technique. *Ingeniería e Investigación*, 37(2), 82-88. DOI: 10.15446/ing.investig.v37n2.62625



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source: Lower input-resistance when the bulk is being used as signal input (Haga, 2009) and reduced signal dynamic range, since any the bulk-source or the bulk-drain junctions can be turned on, ending so, proper transistor function (Molinar-Solis, 2015).

The use of QFG transistors in MOS technology was introduced as an alternative to solve the “initial-charge” problem presented in true floating-gate transistors used for low-power implementations. Since then, it has been successfully used in analog applications ranging from base-band (Algueta-Miguel, 2011) to radio frequency (Xiang, 2012). The basic idea behind QFG circuits is to connect the transistor’s gate to a bias point using a coupling capacitor and a very high resistance device (HiR). The key element is to use this capacitive coupling as a “floating battery” to control the AC response of the QFG transistor reducing the voltage supply requirements and consequently allowing low-voltage operation. In this work, the QFG concept is used to improve the flipped voltage follower (FVF) (Ramirez-Angulo, 2002) for achieving combined low-voltage and class AB operation.

This paper is organized as follows: In the next section, the proposed circuit is presented and explained. Section 3 presents some simulations of the proposed circuit using Spice and experimental results are discussed. Finally, in Section 4 conclusions are presented.

Quasi-floating Gate Flipped Voltage Follower

The proposed circuit is depicted in Figure 1. Transistors M1 to M3 form the basic structure of the FVF circuit, while M6 and HiR construct the biasing point for M5, which is in fact the QFG device. This transistor achieves class AB operation for this circuit in combination with M1; the circuit can be explained as follows: Considering large signal operation, the voltage swing at node “x” is coupled to gate of M5 through C1; if V_x rises, M5 is turned-off while v_{gs} M1 is increased allowing M1 to sink large amounts of current from the output load. In contrast, if V_x falls, M1 is turned-off and M5 is turned “on”, delivering more current to the output load (node “Vo”). For a proper operation of the circuit, it is required to M2 remain in saturation, then in DC $V_x \approx V_{GS_{M1}} + 2V_{DS_{sat}} + V_{osw}$ with $V_{DS_{sat}}$ defined as the saturation drain-source voltage of a transistor, given by $V_{DS_{sat}} \geq V_{GS} - V_{THN}$. Where V_{THN} is the threshold voltage of the NMOS transistor and the output swing is represented by V_{osw} . Therefore, V_x must swing to control M1 and M5 but preserving M2 in saturation.

The capacitor C1 is a 2pF double poly-silicon parallel-plate structure and transistors sizes are depicted on Table I. There are several ways in CMOS technology to accomplish the required high value resistor (HiR) (Ramirez-Angulo, 2002). In this implementation, HiR was accomplished by two back to back connected diodes made by N-well and P+diff, as shown in Figure 2.

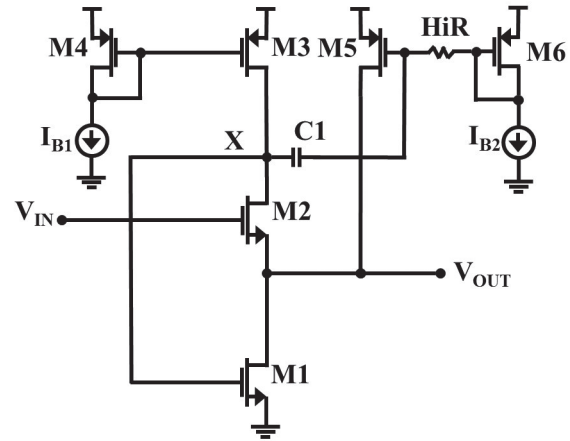


Figure 1. Quasi-floating gate flipped voltage follower.
Source: Authors

This diode structure was chosen because it presents a very low leakage current when is reverse-biased. Due to the lack of reliable diode models in the used technology, the diode voltage drop was characterized by measurements, resulting to be around 0,3V in 40 tested samples.

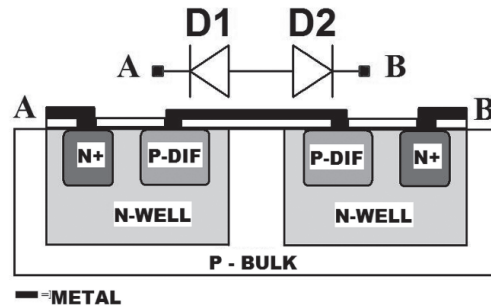


Figure 2. Back to back diodes used to implement HiR.
Source: Authors

The small signal model of the FVF is depicted in Figure 3, where $g_{mX} = gm1 + gm5$ and the bulk effect presented by the input transistor M2 is included by means of g_{mbM2} . The output conductances of devices M_i are represented by g_{oi} . From this model, an approximated expression for the voltage gain (A_v) of the proposed circuit was obtained by nodal analysis:

$$A_v = \frac{V_o}{V_{IN}} = \frac{g_{mM2}(g_{mM1} + g_{O3})}{g_{mM1}(g_{mM2} + g_{mbM2})} \approx \frac{g_{mM2}}{(g_{mM2} + g_{mbM2})} \quad (1)$$

Table 1. Voltage follower transistors size

Transistor	Aspect ratio W/L (mm/mm)
M1, M2	4,8/1,5
M3	21,3/3
M5	21,3/1,5

Source: Authors

denominator of Equation (7) in the general form (Allen, 2002): $s^2 + 2\omega L\xi s + \omega L^2$, the following expression is found for ξ :

$$\xi = \frac{g_{m2} + g_{mb2}}{2C_L \sqrt{\frac{g_{m1}(g_{m2} + g_{mb2})}{C_L C_T}}} \quad (8)$$

From Equation (8), solving for C_T , and recalling that $C_T = C_X + C_C$, it is produced:

$$C_C = \frac{4C_L g_{m1} \xi^2}{g_{m2} + g_{mb2}} - C_X \quad (9)$$

With $\xi = 0,6$, the compensation capacitor results in $C_C \approx 12\text{pF}$, while the nulling resistor $R_Z \approx 1\text{ k}\Omega$.

Simulation and Measurement Results

The proposed feedback action over M1 and M5 is presented in Figure 5, which shows the simulated drain current. A transient analysis simulation was performed considering a 200mVpp square input voltage, V_{in} , and a DC bias of 1,3V at 2 MHz using LTSpice simulator (Linear, 2014). The complementary action of $I_d(M1)$ and $I_d(M5)$ is noticed in the plot, (Figure 5a), showing the source/sink current capability beyond the bias current.

The voltage at node "x" (V_x as shown in Fig. 5b), controls the sourcing/sinking current of M5 y M1 respectively with a capacitive load of $C_L = 18\text{pF}$. As expected, the output V_o follows correctly the input V_{in} square signal. However, at node "x", both the drain of M2 and M3 are tied together, therefore is an inverting point with respect to the input-voltage. Consequently, as it can be observed in Figure 5a, as V_{in} goes down, V_x goes up, lowering V_{GS5} , thus, less current through M5 is available to be added to the current of M1 increasing the time needed to discharge the load capacitance. This is a direct result of the negative feedback present at this node, which tends to stabilize its voltage. The final effect is an asymmetry in V_o regarding rise- and fall- times of the cell.

The microphotograph of the fabricated prototype is shown in Figure 6. The coupling capacitor $C1$ is at the middle of the circuit. The HiR structure lies left of the capacitor, which is in the middle of the cell. This block occupies a height of $92\text{ }\mu\text{m}$ and a width of $85\text{ }\mu\text{m}$. The test chip was fabricated in a $0,5\text{ }\mu\text{m}$, N-well, double poly CMOS technology available through The MOSIS Service.

To test the proposed cell, biasing currents I_{b1} and I_{b2} were fixed to $100\text{ }\mu\text{A}$ and $60\text{ }\mu\text{A}$, respectively, by means of trimming resistors added externally to the chip. The used voltage supply was $V_{DD} = 1,5\text{V}$. The values of the compensation network were adjusted to $R_C = 1,2\text{ k}$ and

$C_C = 10\text{pF}$. Two biasing resistors forming a voltage divider were added to provide voltage bias to the input.

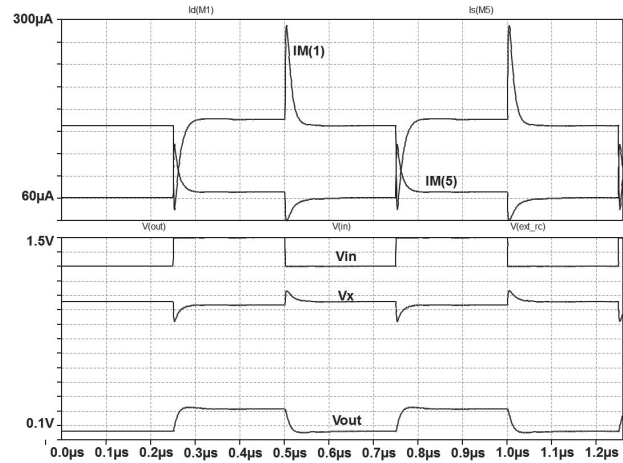


Figure 5. Transient simulation with a 200mV square input signal; a) M1 and M5 drain currents (above); b) input/output voltages traces (below). Source: Authors

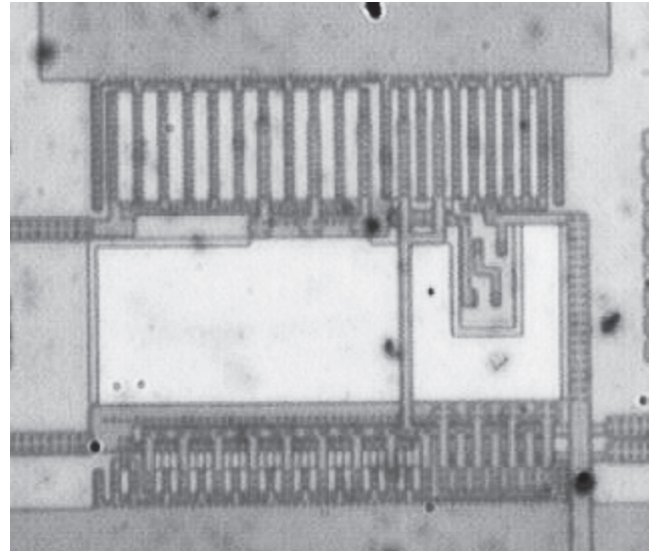


Figure 6. Microphotograph of the fabricated prototype. Source: Authors

An experimental measurement of the test prototype is shown in Figure 7. The test was performed using a square signal V_{in} of $200\text{mVpp}@2\text{MHz}$ with a DC offset of 1,3V added by the mentioned biasing resistor. The output follows the input voltage with a load $C_L = 22\text{pF}$ parallel connected to a resistor $R_L = 10\text{M}\Omega$, this load is due to PCB parasites and oscilloscope probes. Test equipment characteristics are summarized in Table II

An oscilloscope plot of the low frequency transfer function of the circuit, V_{in} vs. V_o (mode X-Y), is shown in Figure 8. The slope of the trace suggests a voltage gain below one approximately 0,8, as suggested by Expression (1), this was later confirmed by an S-parameter measurement performed with a network analyzer; this plot shows a gain bandwidth product of 10 MHz (Figure 9).

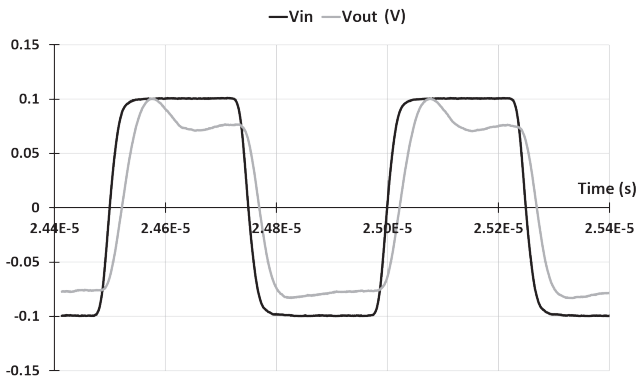


Figure 7. Oscilloscope traces for a 200mVpp square input signal at 2 MHz.

Source: Authors

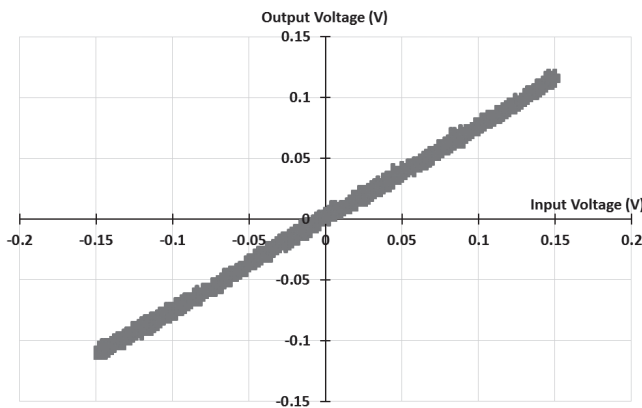


Figure 8. Low frequency transfer function of the circuit under test.

Source: Authors

Table 2. Test equipment data

Instrument	Characteristics
Keithley 2231A 30-3	Triple Channel DC Power Supply
Tektronix MSO 2002B	Digital Oscilloscope 70MHz-1GS/s
Tektronix AFG 1022	25MHz-125MS/s

Source: Authors

In Figure 10, the linearity of the cell was characterized by means of the Fast Fourier Transform (FFT). After noticing the gain bandwidth product of the proposed follower, a test tone of 1MHz was introduced to the circuit, this frequency value was taken since it is where the test equipment has the best spectral purity. The output response of the circuit was traced in a digital-storage oscilloscope. This trace was captured at a sample rate (f_s) $f_s = 12,5$ MSamples per second in an external memory and thereafter processed off-line. The FFT was applied to the captured data. In the resulting power-spectral density trace, the main tone and its harmonics were identified with a simple algorithm (Jaeger, 2011) written in Octave (GNU Octave, 1993). After that, the total harmonic distortion (THD) was computed per the classic expression:

$$THD = \sqrt{\sum_{i=2}^5 V_i^2} / V_1 \times 100\% \quad (10)$$

Due to the elected f_s , only the first 5 harmonics (2...6 MHz) were included in the analysis, since the obtained spectrum is symmetrical at $f_s/2$. The spectrum of the output signal from the chip is depicted in Figure 10. An experimental measurement of total harmonic distortion, $T_{HD} = 1,12\%$ was obtained at 1 MHz, for an input amplitude of 140mV.

A comparison with other class-AB FVF's is presented in Table III. As can be noticed, the output resistance in this approach suggests an important improvement over other proposals when the circuit brings current to the output. The minimum voltage supply VDD and the power consumption is competitive to other approaches, therefore could be considered for low-voltage applications.

Table 3. Comparison among other class-AB FVF

Work	Ro when sourcing current	Minimum VDD	Supply current
Ramirez-Angulo (2006)	1/gm	$V_{GSP} + 2V_{DSat}$	I_b
Jimenez (2006)	1/gm	$V_{GSN} + V_{DSat}$	$2I_b$
Centurelli (2011)	1/gm	$V_{GSP} + 2V_{DSat}$	$3I_b$
This work	$1/[(gm)2ro]$	$V_{GSN} + 2V_{DSat}$	$2I_b$

Source: Authors

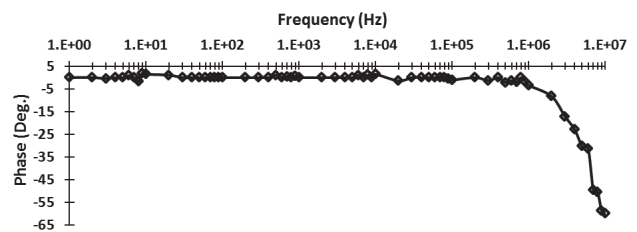
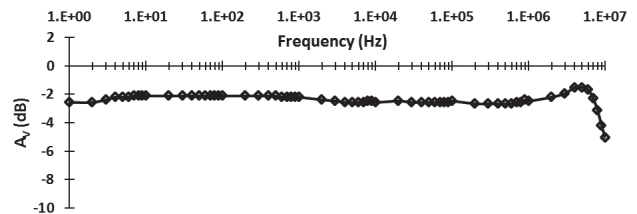


Figure 9. Measured Bode plot of the device.

Source: Authors

Conclusions

The design of a low-voltage class AB voltage follower was presented. In the proposed approach, class AB operation is accomplished by means of using a QFG MOS device connected in a negative feedback loop. A test prototype was fabricated in a CMOS 0,5mm double-poly process, where the threshold voltage of the devices is: $V_{THN} = 0,7V$ and $V_{THP} = -0,98V$, for the N- and P- MOS transistors, respectively.

The test-cell was characterized and experimental results were presented bringing the following performance; a measured voltage gain $A_v = 0,77$; gain bandwidth product

of 10 MHz and a THD of 1,12% @1 MHz. This building block occupies a silicon area of $92\mu\text{m} \times 85\mu\text{m}$ and has a power consumption of $270\mu\text{W}$. An expression for the voltage gain of this circuit was presented, which is accurate with respect to the measured value.

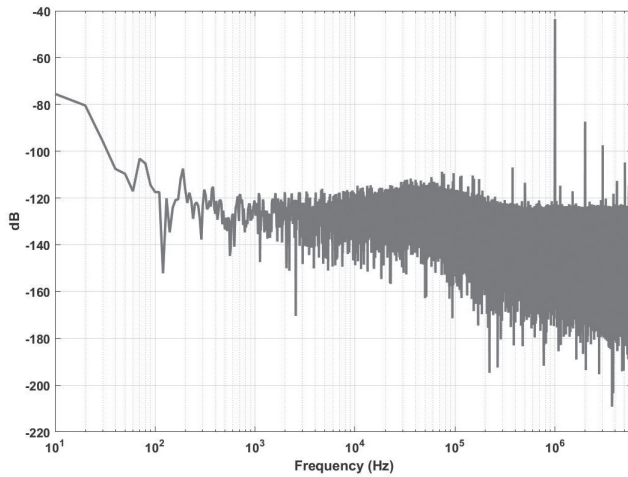


Figure 10. THD at 1 MHz.

Source: Authors

To conclude the present work, the figures of merit (FOM), proposed in Leung (2008), Peng (2004) and Leung (2000) are used to compare the proposed solution with other similar works: Ramirez-Angulo (2006), Jimenez (2006) and Centurelli (2011). The results are summarized in Table IV.

Table 4. Different FOM_s for the cited class-AB FVF

Work	FOM_L	FOM_s (MHzpF/mW)	FOM_R
Ramirez-Angulo (2006)	8,36	0,00188	0,63
Jimenez (2006)	15	0,006	0,48
Centurelli (2011)	-	0,00158	0,416
This work	4	0,001	0,33

Source: Authors

The large-signal FOM_L is dimensionless and defined as:

$$FOM_L = \frac{\min(I_+, I_-)}{I_{bias}} \quad (11)$$

Where I_+ is the positive-peak output current, I_- the negative-peak output current and I_{bias} the total quiescent bias current. The small signal FOM_s is given by:

$$FOM_s = \frac{B_w C_L}{P_{DISS}} \quad (12)$$

Where B_w is the Bandwidth (MHz), C_L the load capacitance (pF) and P_{DISS} (mW) the total quiescent power dissipation. Finally, the signal-range Figure of Merit is dimensionless and defined by, FOM_R :

$$FOM_R = \frac{V_{OPP}(MAX)}{V_{PS}} \quad (13)$$

Here, $V_{OPP}(MAX)$ states for the maximum peak to peak voltage at the output and V_{PS} is the power supply voltage.

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